

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/706,598	SAKUYAMA ET AL.	
Examiner		Art Unit	Ali Bayat	
		2624	Page 1 of 1	

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-			
B	US-2002/0196851	12-2002	Lecoutre, Cedric Arnaud	375/240.12
C	US-6,587,508	07-2003	Hanamura et al.	375/240.24
D	US-6,259,741	07-2001	Chen et al.	375/240.26
E	US-2002/0154823	10-2002	Okada, Shigeyuki	382/233
F	US-2005/0008341	01-2005	Yada et al.	386/113
G	US-2003/0002581	01-2003	Moni et al.	375/240.03
H	US-2006/0088098	04-2006	Vehvilainen, Markku	375/240.03
I	US-7,170,938	01-2007	Cote et al.	375/240.03
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.